SHIGA7.045APC PATENT

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Masuda et al.

Appl. No. : 10/568,126

Filed: February 14, 2006

For : POSITIVE PHOTORESIST

COMPOSITION AND RESIST

PATTERN FORMATION

Examiner : Chu, John S Y.

Group Art Unit : 1752

## RESPONSE TO OFFICE ACTION

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

Dear Sir:

In response to the Office Action mailed **December 5, 2007**, please consider the following remarks:

The listing of claims begins on page 2 of this paper solely for the Examiner's convenience. No amendments have been made.

Remarks/Arguments begin on page 4 of this paper.